

#3

Marking

.200

(5.08)

#4

#1

.130

(3.3)

Description

Xsis Electronics "XH40" Series High Temperature crystal oscillators are designed and processed to operate over an extended temperature range of -55 °C to 230 °C. These oscillators are offered in a low profile, hermetically sealed resistance welded 7x9 mm ceramic package.

High temperature materials and proven processes are utilized to provide high reliability and long life at extreme temperatures.

In addition, the quartz crystal is mounted at four points to provide excellent shock and vibration resistance.

Features

- Crystal Mounted at 4 Points
- > 10KG (0.3 mS) Shock Resistance
- 1.8V, 2.5V, 3.3V & 5.0V operation options
- 100% testing over operating temperature range
- Tristate Output Option
- Low Phase Noise
- Hermetically Sealed, Ceramic Package
- Tape & Reel packaging
- Made in USA, ECCN: EAR99

Applications

- Downhole Drilling Operations
- High Shock & Vibration
- High Temperature Avionics
- Gun Launched Munitions
- Jet Engine Sensors

Package Specifications & Outline:

- Package: Ceramic 90% AL₂ O₃
- Seal: Hermetic Resistance Welded
- Weight: 0.5 Gms Typical, 0.6 Gms Max.
- Thermal Resistance, Junction to Case (θ_{JC}): 30 °C / Watt
- Solder Reflow, Temp./Time: 260 °C Max for 10 Seconds Max.
- Pad Finish: 1.27 to 2.2 µm gold over 1.27 to 8.9 µm nickel

Hot Solder Tinning per MIL-PRF-55310 is optional at additional cost.

Contact Xsis Electronics at xsis@xsis.com for any special requirements.

#2 .200 <u>+</u> .005 .290 <u>+</u> .005 (5.08 <u>+</u> .13) .040 (7.4 ± .13) (1.0) Тур. 140 Max (3.56).018 <u>+</u> .003 .240 <u>+</u> .005 (.46 <u>+</u> .08) (6.1 <u>+</u> .13) .350 <u>+</u> .005 .008 <u>+</u> .001 (8.89 <u>+</u> .13) (.20 + .03) €.070 Dimensions: Inches (mm) (1.78) LEAD# FUNCTION Typical PCB .240 1 E/D (Optional) Layout (6.1)2 GND/CASE OUTPUT 3 4 VDD

E/D (Enable/Disable) Input: A "Low" level at the input disables the Output into a high impedance state.

E/D Input has internal pull-up. It can be left floating or connected to Vdd.

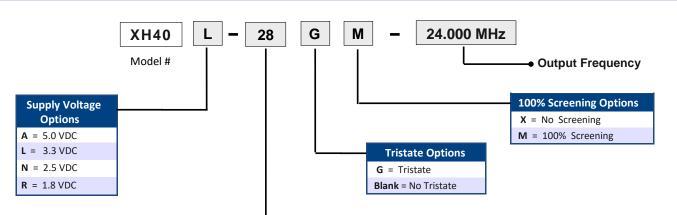
Rev 06/17

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ORDERING INFORMATION (Please build your part number from options below):

P/N EXAMPLE: XH40 L – 28GM - 24.000 MHz 3.3 V LVHCMOS, <u>+</u> 150 PPM Frequency Accuracy over -55 °C to +180 °C, Tristate Output, 100% Screening, 24.000 MHz



Fre	auenc	v Acc		Vs, Op	erat	ing	
		-		ge Opti			
21 =	<u>+</u> 40					+150°C	***
22 =	<u>+</u> 100	PPM	over	-20 °C	to	+150 °C	*
23 =	<u>+</u> 150	PPM	over	-20 °C	to	+150 °C	*
24 =	<u>+</u> 40	PPM	over	-20 °C	to	+180°C	***
25 =	<u>+</u> 100	PPM	over	-20 °C	to	+180 °C	***
26 =	<u>+</u> 150	PPM	over	-20 °C	to	+180 °C	*
27 =	<u>+</u> 100	PPM	over	-55 °C	to	+180 °C	***
28 =	<u>+</u> 150	PPM	over	-55 °C	to	+180 °C	*
29 =	<u>+</u> 250	PPM	over	-55 °C	to	+180 °C	*
30 =	<u>+</u> 100	PPM	over	-20 °C	to	+200 °C	***
31 =	<u>+</u> 150	PPM	over	-20 °C	to	+200 °C	**
32 =	<u>+</u> 200	PPM	over	-20 °C	to	+200 °C	*
33 =	<u>+</u> 250	PPM	over	-20 °C	to	+200 °C	*
34 =	<u>+</u> 100	PPM	over	-55 °C	to	+200 °C	***
35 =	<u>+</u> 150	PPM	over	-55 °C	to	+200 °C	***
36 =	<u>+</u> 200	PPM	over	-55 °C	to	+200 °C	*
37 =	<u>+</u> 250	PPM	over	-55 °C	to	+200 °C	*
38 =	<u>+</u> 200	PPM	over	-55 °C	to	+220 °C	***
39 =	<u>+</u> 300	PPM	over	-55 °C	to	+220 °C	*
40 =	<u>+</u> 250	PPM	over	-20 °C	to	+230 °C	***
41 =	<u>+</u> 350	PPM	over	-20 °C	to	+230 °C	*
42 =	<u>+</u> 250	PPM	over	-55 °C	to	+230 °C	***
43 =	<u>+</u> 350	PPM	over	-55 °C	to	+230 °C	*

*** Tight Stability

* Standard Stability

Contact Xsis Electronics at xsis@xsis.com (913-631-0448) for any special requirements.



Electrical Specifications, 5V & 3.3V HC/ACMOS Oscillators

Parameter	5 V HC/ACMOS	3.3 V HC/ACMOS			
Output Frequency Range	500 KHz - 40 MHz	500 KHz - 40 MHz			
Frequency Stability Vs Temperature	See Ordering Information on Page 1				
Operating Temperature Range	See Ordering Information on Page 1				
Supply Voltage (Vdd)	+ 5 VDC <u>+</u> 10%	+ 3.3 VDC <u>+</u> 10%			
Input Current (no Load)	9 mA typical at 20 MHz (For Lower current option, Contact factory)	5 mA typical at 20 MHz (For Lower current option, Contact factory)			
Output Waveform	Square Wave	Square Wave			
Output Duty Cycle (at 50% Output Level)	40/60% Max. (For tighter symmetry, Contact factory)	40/60% Max. (For tighter symmetry, Contact factory)			
Output High Level	0.9 Vdd Min.	0.9 Vdd Min.			
Output Low Level	0.1 Vdd Max.	0.1 Vdd Max.			
Output Load	10K // 15 pF 50 pF Max.	10K // 15 pF 50 pF Max.			
Rise & Fall Times (Typical Load)	3 nS Max. (10% to 90% Output Levels)	4 nS Max. (10% to 90% Output Levels)			
Enable/Disable (E/D)	E/D Input ≥ 2.2V or Open:Normal Output E/D Input ≤ 0.8V: High Impedance				
Start-Up Time	10 mS Max.	10 mS Max.			
Phase Jitter (10 KHz - 20 MHz Integ.)	0.5 pS rms Typical	0.5 pS rms Typical			
Aging at 70 °C	<u>+</u> 3 PPM Max. first year, <u>+</u> 2 PPM Max. per year thereafter				
Absolute Maximum Applied Voltage	+ 7VDC	+ 5VDC			
Storage Temperature	-65 °C to +125 °C	-65 °C to +125 °C			

NOTE: Overall Frequency Accuracy Includes, Initial Accuracy at 25 °C, Frequency changes over Operating Temperature, Aging over 5 years, Frequency changes due to Supply Voltage & Load Variations.

For special requirements, such as, tighter output symmetry, faster start-up time, PIND screening, etc., please contact Xsis Electronics at xsis@xsis.com or call us at 913-631-0448.



Electrical Specifications, 2.5V & 1.8V LVHCMOS Oscillators

Parameter	2.5 V HC/ACMOS	1.8 V HC/ACMOS			
Output Frequency Range	500 KHz - 40 MHz	500 KHz - 40 MHz			
Frequency Stability Vs Temperature	See Ordering Information on Page 1				
Operating Temperature Range	See Ordering Information on Page 1				
Supply Voltage (Vdd)	+ 2.5 VDC <u>+</u> 10%	+ 1.8 VDC <u>+</u> 5%			
Input Current (no Load)	3.5 mA Typ. at 20 MHz (For Lower current option, Contact factory)	3 mA Typ. at 20 MHz (For Lower current option, Contact factory)			
Output Waveform	Square Wave	Square Wave			
Output Duty Cycle (at 50% Output Level)	40/60% Max. (For tighter symmetry, Contact factory)	40/60% Max. (For tighter symmetry, Contact factory)			
Output High Level	0.9 Vdd Min.	0.9 Vdd Min.			
Output Low Level	0.1 Vdd Max.	0.1 Vdd Max.			
Output Load	10K // 15 pF 30 pF Max	10K // 15 pF 30 pF Max.			
Rise & Fall Times (Typical Load)	< 30 MHz 6 nS Max. ≥ 30 MHz 3 nS Max. (10% to 90% Output Levels)	< 30 MHz 6 nS Max. ≥ 30 MHz 3 nS Max. (10% to 90% Output Levels)			
Enable/Disable (E/D)	able/Disable (E/D) E/D Input ≥ 0.7 Vdd or Open : Normal Output E/D Input ≤ 0.3Vdd: High Impedance				
Start-Up Time	10 mS Max.	10 mS Max.			
Phase Jitter (10 KHz - 20 MHz Integ.)	0.5 pS rms Typical	0.5 pS rms Typical			
Aging at 70 °C	\pm 3 PPM Max. first year, \pm 2 PPM Max. per year thereafter				
Absolute Maximum Applied Voltage	+ 5VDC	+ 5VDC			
Storage Temperature	-65 °C to +125 °C	-65 °C to +125 °C			

NOTE: Overall Frequency Accuracy Includes, Initial Accuracy at 25 °C, Frequency changes over Operating Temperature, Aging over 5 years, Frequency changes due to Supply Voltage & Load Variations.

For special requirements, such as, tighter output symmetry, faster start-up time, PIND screening, etc., please contact Xsis Electronics at xsis@xsis.com or call us at 913-631-0448.



Packaging: Tape & Reel, EIA-481-A Compliant

Thermal Characteristics:

Junction to case Thermal Constant (θ_{JC}): 38 $^{\circ}\text{C}$ / Watt

Typical Phase Noise (dbc/Hz):

Output Frequency	10 Hz	100 Hz	1 KHz	10 KHz	100 KHz	1 MHz
10 MHz	- 90	-122	-145	-158	-161	-164
25 MHz	-83	-111	-135	-143	-149	-157
40 MHz	-81	-108	-133	-142	-146	-154

Environmental Specifications:

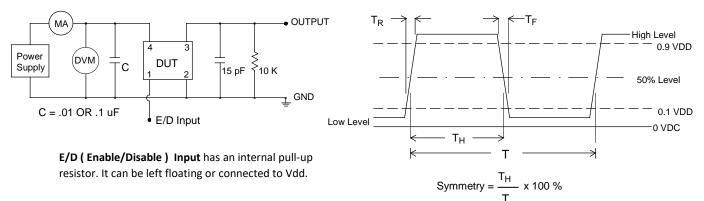
XH40 series oscillators are designed to meet or exceed the Environmental tests specified below. Customized screening and environmental testing are also available to meet your special requirements.

Test	Test Conditions
Vibration	0.06" DA, 30 G peak, 10 - 2000 Hz, MIL-STD-202, Method 204, Cond. G
Shock	5000 G, 0.3 mS, half-Sine, MIL-STD-883, Method 2002, Cond. D
Temperature Cycling	MIL-STD-883, Method 1010, Cond. C
Thermal Shock	MIL-STD-202, Method 107, Cond. B
Seal (Fine and Gross)	MIL-STD-883, Method 1014 Cond. A & C
Burn-in	160 Hours, 125 °C, Nominal Supply Voltage & Load
Frequency Aging	30 days at 70 °C, <u>+</u> 1.5 PPM Max.
Altitude	MIL-STD-202, Method 105, Cond. C
Constant Acceleration	MIL-STD-883, Method 2001, 5000 G
Moisture Resistance	MIL-STD-202, Method 106, Vibration Sub Cycle Omitted
Solderability	MIL-STD-202, Method 208
Resistance to Soldering Heat	MIL-STD-202, Method 210, Cond B. or C as applicable
Resistance to Solvents	MIL-STD-202, Method 215
Internal Water Vapor Content	MIL-STD-883, Method 1018
ESD Classification	MIL-STD-883, Method 3015, Class 1C, HBM 1000 to 1999
Moisture Sensitivity Level	J-STD-020, MSL=1

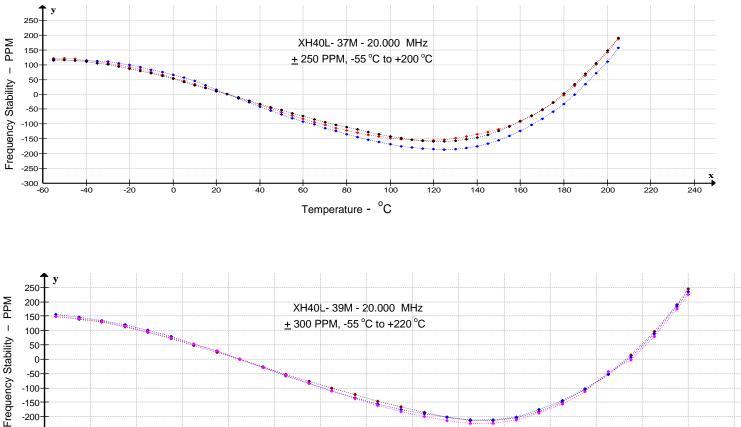


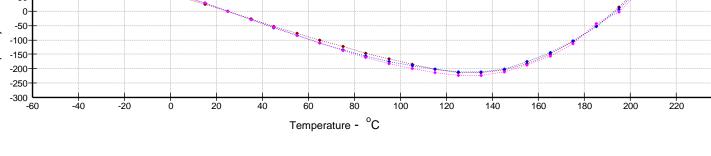
HCMOS Test Circuit





Typical Freq. Stability Vs. Temperature





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